FORM PTO 1449 (modified)				ATTY DOCKET NO. 03500.017551.	APPLICATION NO. 10/658,397 O P E VC			
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				APPLICANT KAZUMI KIMURA JUN 0 7 200			0 7 2004 g	
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EXAMINER	Jan	nes f	han	DATE CONSIDERED 11	104			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) JUL 2 0 2006.			FILING DATE September 10, 2003	FILING DATE September 10, 2003 GROUP 2872				
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J.P	"Principle of Optics III", Tokai University Press, p. 1030 (with English-language translation).							
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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